Search Notes							

Application/Control No.	Applicant(s)/Patent Reexamination	Applicant(s)/Patent under Reexamination	
10/763,204	MIYAJIMA, AKIRA		
Examiner	Art Unit		
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SEARCH NO (INCLUDING SEARC)
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East (USPAT; US-PGPUB) 370/352,356, 392 and text Text search only Scarcy, updated	7/10/2007 8-7-08	рн РИ
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